

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10573410	BITAR ET AL.
<b>Examiner</b>		<b>Art Unit</b>
Dager, Jonathan M		3663

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
719	all	12/17/2007	JD
701	all	12/17/2007	JD
342	all	12/17/2007	JD
405	all	12/17/2007	JD
700	all	12/17/2007	JD
702	all	12/17/2007	JD
703	all	12/17/2007	JD
706	all	12/17/2007	JD

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor	12/17/2007	JD
Class	12/17/2007	JD
IDS	12/17/2007	JD
PCT information	12/17/2007	JD
Keyword	12/17/2007	JD
INVENTOR SEARCH IN PALM	7/21/2008	JD
REVIEW OF PRIOR ART	7/21/2008	JD
CITATION OF BEST PRIOR ART	7/21/2008	JD
KEYWORD	7/21/2008	JD
CITATION OF BEST PRIOR ART	4/27/2009	JD
IDS	4/27/2009	JD
ASSIGNEE	4/27/2009	JD
INVENTOR	4/27/2009	JD
KEYWORD	4/27/2009	JD
NPL (IEEE, GOOGLE)	4/27/2009	JD
ASSIGNEE	11/20/2009	JD
INVENTOR	11/20/2009	JD
CITATION OF CLOSEST PRIOR ART	11/20/2009	JD
KEYWORD	11/20/2009	JD
KEYWORD	3/2/2010	JD
CITATION OF BEST PRIOR ART	3/2/2010	JD
INVENTOR	3/2/2010	JD
ASSIGNEE	3/2/2010	JD

## SEARCH NOTES

Search Notes	Date	Examiner
PATENTABLE MATERIAL CONFERENCE WITH ROBERT SWIATEK, PE AU 3643	3/2/2010	JD
INTERFERENCE (SEE BELOW)	3/2/2010	JD
QUALITY REVIEW MEETING	3/2/2010	JD

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
244	17.13,75.1-76,174-188	3/2/2010	JD
340	945,947,961,963-982,988,995.1-996	3/2/2010	JD
342	63-66,118-121,350-352,357.01,357.06,134,139,140	3/2/2010	JD
701	1,3,4,7-11,14,23,25-28,200-214,300-302	3/2/2010	JD